

Search Notes

Application/Control No.

10/062,700

Examiner

Djenane M. Bayard

Applicant(s)/Patent under
Reexamination

LAU ET AL.

Art Unit

2141

SEARCHED

Class	Subclass	Date	Examiner
370	252	2/7/2009	DB

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	2/7/2006	DB